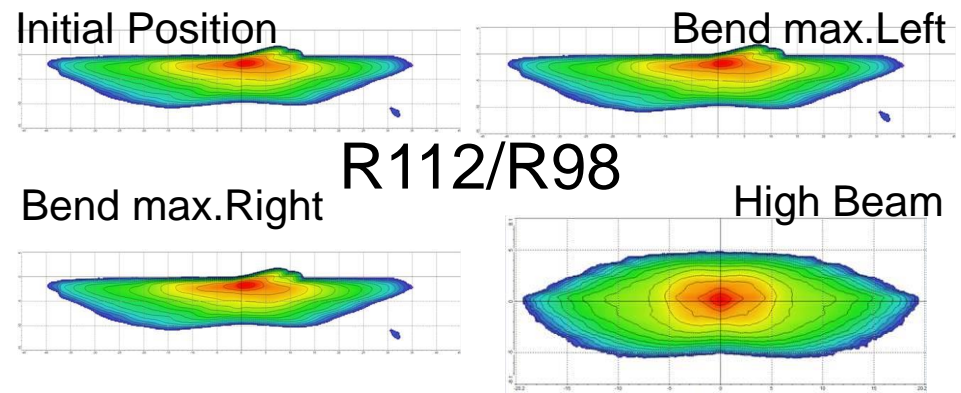
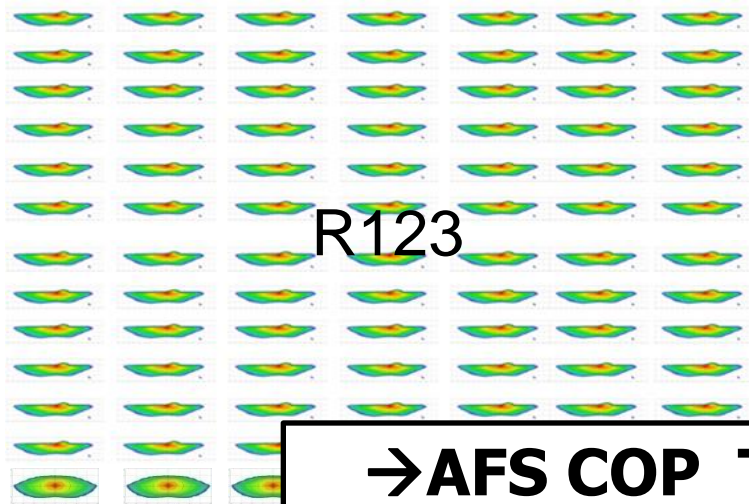


GTB Task Force Conformity of Production TF CoP

Report for GRE-75

Motivation for TF CoP on AFS

- to set R123 in line with other headlamp CoP procedures to have common CoP procedures for work of **IWG-SLR**
- to show R123 CoP compliance up to **80** photometric measurements are necessary compared to only **8** measurements for HID (R98) or Halogen (R112) headlamps with bendlight



→ AFS COP TESTING HAS TO BE SIMPLIFIED

GTB TF CoP

- in average 15 experts from Industry and Testhouses participated since 2012

Outcome:

- **Work on ECE Reg. 123 to simplify AFS tests for serial production**

GRE Reporting

Regular Progress Report to GRE

69th session([GRE-72-29](#))

72nd session([GRE-69-40](#))

Work items of TF:

- include in Reg.123 the new CoP procedure similar to Reg.112 change adopted at 69th GRE session (ECE/TRANS/WP.29/GRE/2013/37)
- clarify which tests are necessary for CoP testing compared to type approval testing, clarify that tests apply only for the entire system (*Annex 5, Appendix 1 , paragraph 1.*)
- create simplified photometric CoP tables for each class (C,V,W,E,R,R_{ADB}) with applicable tolerances (*Annex 5, Appendix 1 , Tables 1 to 16*)

Work items:

- reduce&simplifiy the measurements
- if there is more than one mode in a Class then only the basic mode for CoP to be measured (*paragraph 2 of Annex 5, Appendix 1*)
- if bending modes use same functional unit, then only worst case bending mode to be measured (*paragraph 2 of Annex 5, Appendix 1*)
- if ADB has same functional unit, then only the worst case situation for CoP to be measured (in most cases this will be Line 1 and Line 4 ("50m case") in *Table 16 Part A of Annex 5, Appendix 1*)
- substitute zone scans by line scans and line-scans by point measurements (*Table 1 to 16 of Annex 5, Appendix 1*)

Work items:

- reduce&simplifiy the measurements
- instead of I_{max} scan usage of characteristic points *(Annex 5, Appendix 1, Table 1, 75R,50V,50R instead of I_{max})*
- allowance of an automatic 0.25° re-aim for CoP tests instead of a re-alignment of the unit without re-testing all other modes for CoP *(Annex 5&7 Paragraph 1.22 and Annex 5, Appendix 1 Paragraph 1)*

Work in Detail:

- update paragraph 9 and Annex 7 with new CoP procedure as adopted by GRE **(GRE 69: ECE/TRANS/WP.29/GRE/2013/37)**

- define which tests are applicable for CoP
 - Photometry according to new CoP Tables in Annex 5
 - Colour
 - Stability of Cut-Off (Annex 4)

- include simplified CoP Tables for Photometry in Annex 5 for each Class/Mode
 - Class C / Class E / Class V / Class W / Class R /R_{ADB}

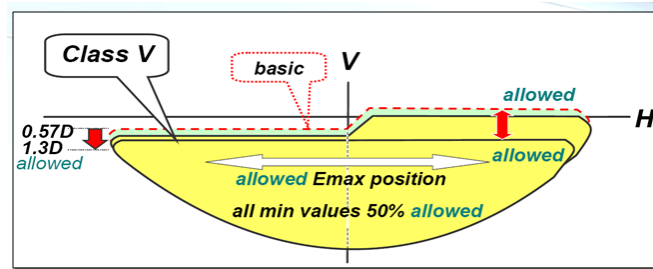
Overview of AFS see [GRE-48-28](#) or [GRE-48-30](#)

Simplify Classes to most important key test points

- **Simplify classes/modes (C,V,W,E,R, R_{ADB}) to most important key test points**

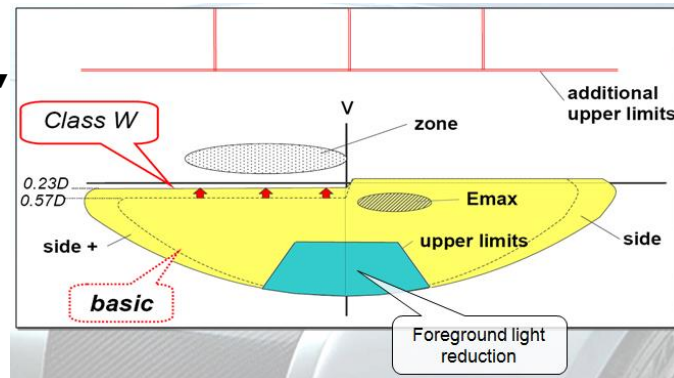
e.g.

- **Class V: "Village"**



→ check reduced kink/ light at crossing

- **Class W: "Wet Road"**



→ check reduced foreground illumination, extended range...

Simplified photometric tables for CoP

- Proposal for a simplified Class C Table for CoP:**

<u>Class C - Neutral State</u>		<i>Position/deg</i>					<i>Column A</i>		<i>Column B</i>		<i>Column C</i>		
<i>Tabled requirements expressed in cd</i>		<i>horizontal</i>			<i>vertical</i>		$\triangleq 0\% \text{ CoP}$		$\triangleq 20\% \text{ CoP}$		$\triangleq 30\% \text{ CoP}$		
<i>No</i>	<i>Element</i>	<i>at/</i>	<i>from</i>	<i>to</i>	<i>at</i>		<i>min</i>	<i>max</i>	<i>min</i>	<i>max</i>	<i>min</i>	<i>max</i>	
1	B50L	L	3.43		U	0.57	50	350	25	520	10	605	
3	BR	R	2.5		U	1	50	1750	25	2100	10	2275	
4	Point BRR	R	8		U	0.57	50	3550	25	4260	10	4615	
5	Point BLL	L	8		U	0.57	50	625	25	880	10	1005	
7	Line III	L	4	V	V	H		625		880		1005	
8a	S50+S50LL+S50RR ³				U	4	190 ²	1875	95 ²	2250	45 ²	2440	
9a	S100+S100LL+S100RR ³				U	2	375 ²	1875	185 ²	2250	90 ²	2440	
10	50 R	R	1.72		D	0.86		44100		52920		57330	
11	75 R	R	1.15		D	0.57	10100	44100	8080	52920	7070	57330	
12	50 V	V			D	0.86	5100	44100	4080	52920	3570	57330	
13	50 L	L	3.43		D	0.86	3550	13200 ⁴	2840	15840 ⁴	2485	17160 ⁴	
14	25 LL	L	16		D	1.72	1180	44100	944	52920	826	57330	
15	25 RR	R	11		D	1.72	1180	44100	944	52920	826	57330	
17	Line 10	L	4.5	R	2.0	D	4		12300 ¹		14760 ¹		15990 ¹

- instead of Line-scan- only a Point-measurement (e.g. Line BRR/BLL -> Point BRR/BLL)
- instead of Zone-scan- only Line-measurement (e.g. ZoneIII -> LineIII)
- instead of Imax scan use characteristic points (75R)

Reduced CoP Tables and Tests

- e.g. **Simplified Class V Table for CoP:**

<u>Class V - Neutral State</u>		<i>Position/deg</i>					<i>Column A</i>		<i>Column B</i>		<i>Column C</i>	
<i>Tabled requirements expressed in cd</i>		<i>horizontal</i>			<i>vertical</i>		$\triangleq 0\% \text{ CoP}$		$\triangleq 20\% \text{ CoP}$		$\triangleq 30\% \text{ CoP}$	
<i>No</i>	<i>Element</i>	<i>at/</i>	<i>from</i>	<i>to</i>	<i>at</i>		<i>min</i>	<i>max</i>	<i>min</i>	<i>max</i>	<i>min</i>	<i>max</i>
1	B50L	L	3.43		U	0.57		350		520		605
3	BR	R	2.5		U	1		880		1135		1260
4	Point BRR	R	8		U	0.57		880		1135		1260
5	Point BLL	L	8		U	0.57		880		1135		1260
7	Line III	L	4	V	V	H		625		880		1005
10	50 R	R	1.72		D	0.86	5100	44100	4080	52920	3570	57330
13	50 L	L	3.43		D	0.86	3550	13200 ¹	2840	15840 ¹	2485	17160 ¹

→ e.g. reduction to key test points

➤ new definition of „functional unit“

“1.22. “Functional unit” means a part of a lighting unit providing a specific light distribution which may be used for different modes or classes. If used for the bending mode its light distribution may vary as a function of the T-signal(turn-radius); however, the light distribution shall be identical for a given T-signal(turn-radius) in all modes or classes.

some examples for such a „functional unit“ for the bending:

for Cat.1 Bendlight:(bending mode with horizontal movement of the kink of the cut-off)

- the swivelling of a complete projection module or only the optical lens
- the activation of static optical elements which produce moveable kink patterns by sequential activation (pixel/matrix light)

etc....

for Cat 2 Bendlight: (bending mode without horizontal movement of the kink of the cut-off)

- the activation of static optical elements (e.g. cornering lamp reflector, pixel/matrix light) below cut off line
- the swivelling of optical elements below cut off line

etc....

- Reduce the measurements according to the following decision table:
- reduction of ADB measurements to worst case condition if same functional unit is used
 - reduction to measurements of only the basic mode if more than one mode in a Class exists
 - reduction of bend light test if same „functional unit“ is used.

(details see next slide)

	“Multiple Modes” - Condition * if more than one mode of the applicable Class exist only the basic mode has to be tested in non-bending mode according to	“Bending Modes” -Condition if the system uses the same functional units to obtain bending modes for more than one class:	
		YES	NO
Class C	Table 1 *		
Category 1 bending mode	→	** the bending modes shall only be tested in the Class which represents the worst condition	Table 2
Category 2 bending mode		Test category 2 bending mode according to Table 3	
Class V	Table 4 *		
Category 1 bending mode	→	see **	Table 5
Category 2 bending mode			Table 6
Class W	Table 7 *		
Category 1 bending mode	→	see **	Table 8
Category 2 bending mode			Table 9
Class E	if more than one mode of Class E exist only the mode Class E which relates to the highest cut-off position has to be tested in non-bending mode according to corresponding table 10 to table 13	No additional testing of Category 1 and/or Category 2 is necessary	

Target:

- formal document to be sent to 76th GRE session for adoption

THANK YOU!